Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/707,749	FUNG ET AL.
Examiner	Art Unit
Y. J. Han	2838

SEARCHED				
Class	Subclass	Date	Examiner	
363	16			
	17	·		
	21.01- 21.18			
	24			
	25			
	37		,	
	97			
	131	9/05	SH	
See sear	ch report	9/05	DA	
	1		94	
see sear	ch report	12/05	94	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
Sce Seal	oh report	12/05	94

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
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